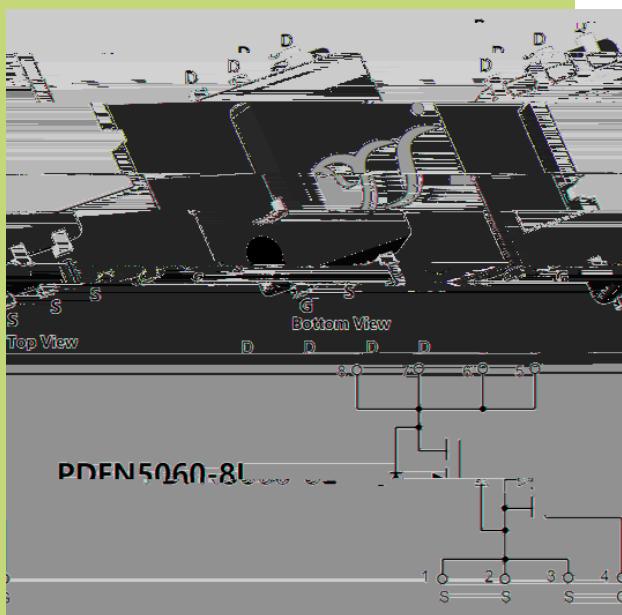


;

Ybh' AcXY' :]Y'X' 9ZZYWh' HfUbg]ghcf''



DfcXiWh'Gi a aUfm'

V_{DS}	40V
I_D	300A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	0.85m
100% EAS Tested	
100% V_{DS} Tested	

; YbYfU' 8YgWf]dh]cb'

- Split gate trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low $R_{DS(O)}$

Absolute Maximum Ratings (A25 un

	Gma Vc''	@]a]h'	I b]h'
	V_{DS}	40	V
	V_{GS}	±20	V
	I_D	43	A
		30	
		300	
		212	
	EAS	1458	mJ
	P_D	3	W
		1.5	
		136	
		68	
	T_J, T_{STG}	-55 +175	

DF9: 9F98' D#B'	D57?-B ; 7C89'	Auf_]b['	A-B-A I A' D57?5 ; 9fidWgk'	-BB9F' 6CL' E I 5BH-HMfidWgk'	C I H9F' 75FHCB' E I 5BH-HMfidWgk'	89@-J9FM' AC89'
YJG300G04HRQ	F1	G300G04HR	5000	10000	100000	13" reel

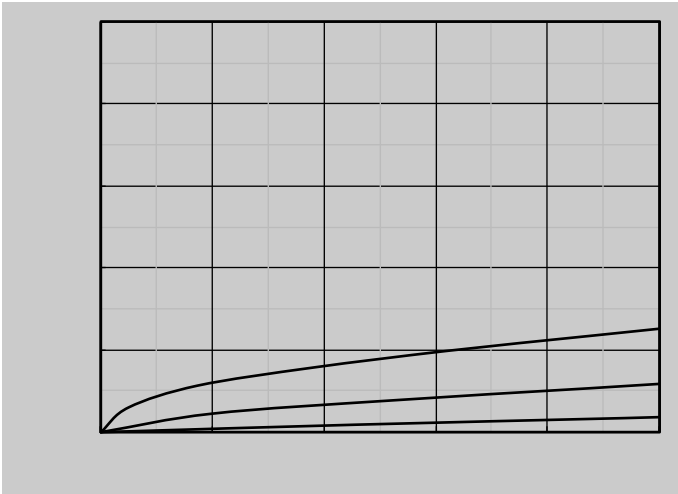


9`YWhf]WU`7 \UfUWhYf]gh]Wg'(T_J=25 unless otherwise noted)

DUfU a YhYf'	Gma Vc''	7cbX]h]cbg'	A]b'
--------------	----------	-------------	------



Hmd]WU`9`YWhf]WU`UbX`H\Yf a U`7\UfUWhYf]gh]Wg'8]U[fU ag`



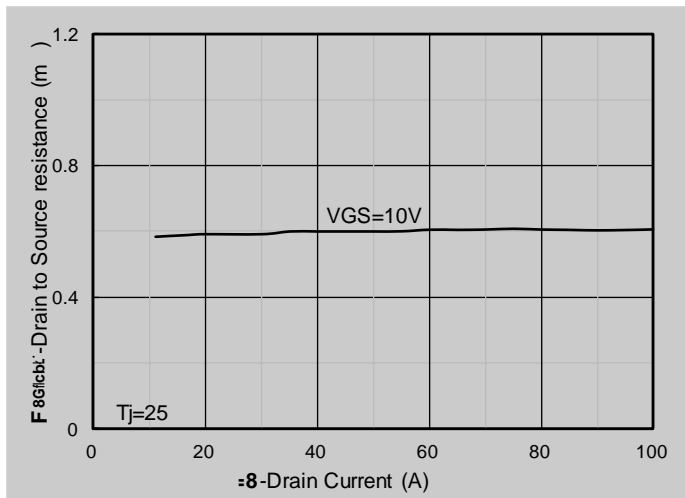


Figure 7. $R_{DS(on)}$ VS Drain Current

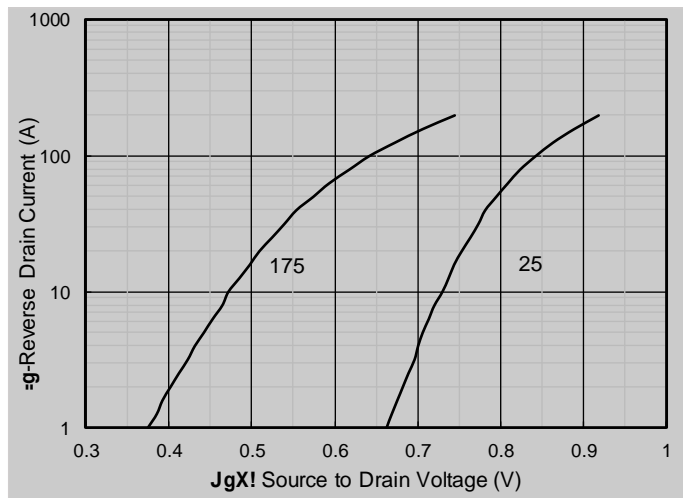


Figure 8. Forward characteristics of reverse diode

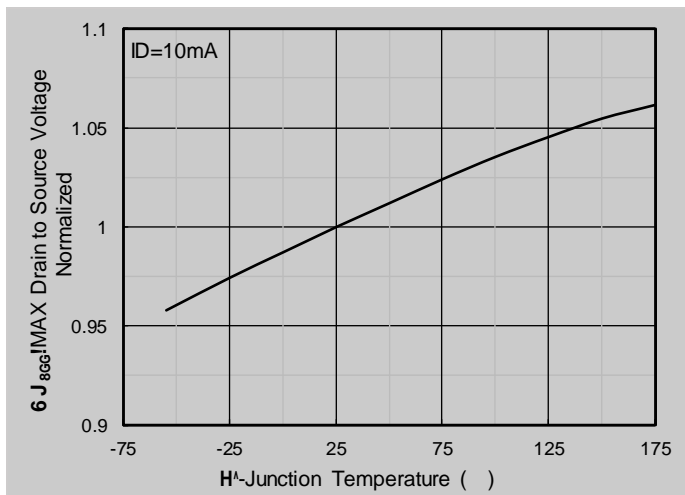


Figure 9. Normalized breakdown voltage

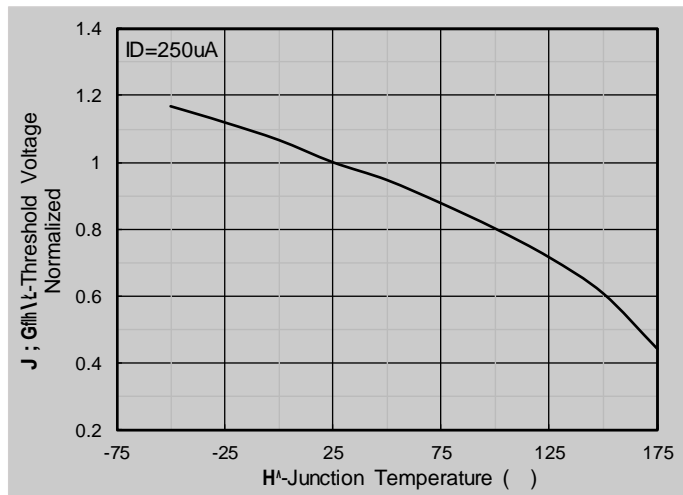


Figure 10. Normalized Threshold voltage

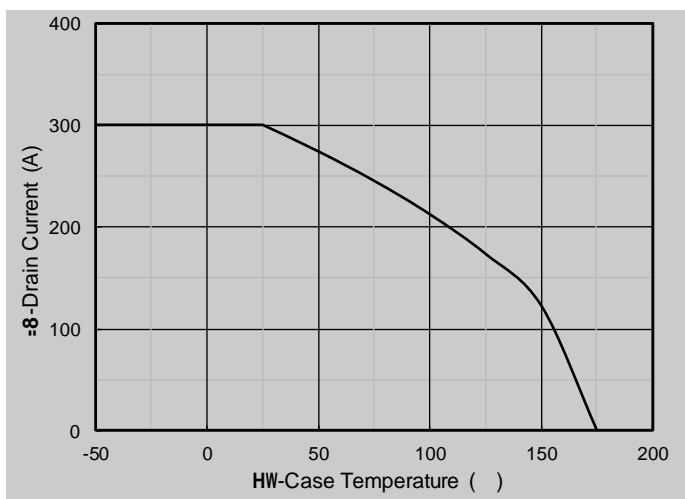
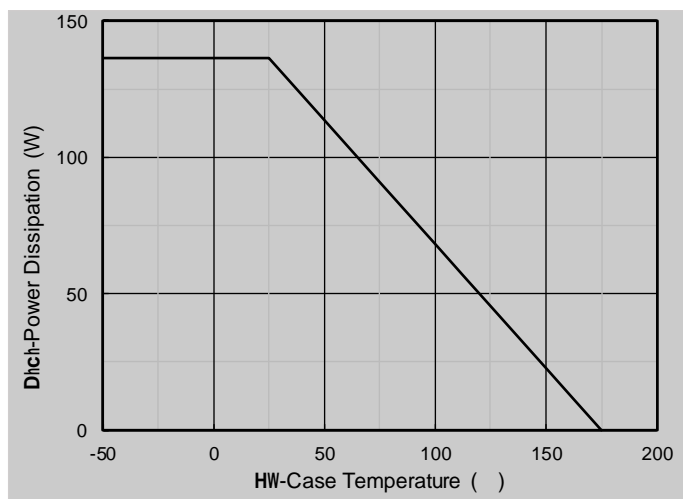
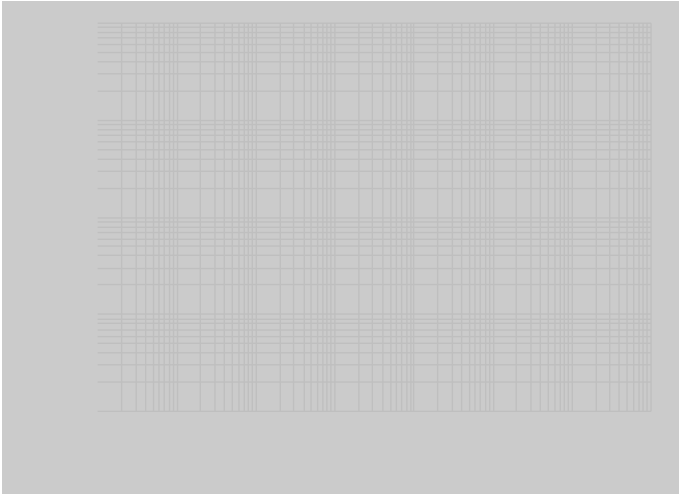


Figure 11. Current dissipation





M> ; '\$\$; \$(< FE'



M> ; '\$\$; \$(< FE'

'LVFODLPHU

7KH LQIRUPDWLRQ SUHVHQWHG LQ WKLV <DQJ> KRXVH QDQV MIRHU (WHIHFWURQ EFRQHFHQW ROR
ULJKW WR PDNH FKDQJH RU ZWLVK RXSWKHU IRU SUDRVGLXFWV RIGWVSOD\HG KHUHLQ WRGLHPSLWRY
RWKHU ZLVH

7KH SURGXFW OLVWJH EHWURLEH LXV BSHZLWKF WXURRERW DYRUQRWHGLQV EHQH FDO OLIH
VDYLQJ OLIHVXVWD <DQJ> R UODQD QHD R QXPMV ERKU DLSREQOLELQRW \DQJGQPDUH
VXFK LPSURSHU XVH RI VDOH

7KLV SXEOLFDFWLRQ SXOSSHUW DQDVLQURQPDVSLRQLSHGHYRURXDGGLRQLRSDODVLRWUHLWWWSX
ZZZ \DQJMLHRURPRQVXOW \RXUH QHD DQJWR B DQJWKWDQFH